

# HAC RF TESTREPORT

No. I16Z42280-SEM03

For

**TCL Communication Ltd.** 

LTE / UMTS / GSM mobile phone

Modelname: 50440

With

**Hardware Version: PIO** 

Software Version: v4HA2

FCC ID: 2ACCJH063

**Results Summary: M Category = M3** 

Issued Date: 2016-12-23



#### Note:

The test results in this test report relate only to the devices specified in this report. This report shall not be reproduced except in full without the written approval of CTTL.

#### **Test Laboratory:**

CTTL, Telecommunication Technology Labs, Academy of Telecommunication Research, MIIT No. 51 Shouxiang Science Building, Xueyuan Road, Haidian District, Beijing, P. R. China100191 Tel:+86(0)10-62304633-2512,Fax:+86(0)10-62304633-2504

Email: <a href="mailto:cttl">cttl</a> terminals@catr.cn, website: <a href="mailto:www.chinattl.com">www.chinattl.com</a>



# **REPORT HISTORY**

Report Number	Revision	Issue Date	Description
I16Z42280-SEM03	Rev.0	2016-12-23	Initial creation of test report



# **TABLE OF CONTENT**

1 TEST LABORATORY	5
1.1 Testing Location	5
1.2 TESTING ENVIRONMENT.	
1.3 Project Data	5
1.4 Signature	5
2 CLIENT INFORMATION	6
2.1 APPLICANT INFORMATION	6
2.2 Manufacturer Information	
3 EQUIPMENT UNDER TEST (EUT) AND ANCILLARY EQUIPMENT (AE)	7
3.1 About EUT	
3.2 INTERNAL IDENTIFICATION OF EUT USED DURING THE TEST	
3.3 INTERNAL IDENTIFICATION OF AE USED DURING THE TEST	
3.4 AIR INTERFACES / BANDS INDICATING OPERATING MODES	
4 CONDUCTED OUTPUT POWER MEASUREMENT	8
4.1 Summary	
4.2 CONDUCTED POWER	8
5 REFERENCE DOCUMENTS	g
5.1 Reference Documents for testing	g
6 OPERATIONAL CONDITIONS DURING TEST	10
6.1 HAC MEASUREMENT SET-UP	10
6.2 PROBE SPECIFICATION	
6.3 TEST ARCH PHANTOM & PHONE POSITIONER	
6.4ROBOTIC SYSTEM SPECIFICATIONS	12
7 EUT ARRANGEMENT	13
7.1 WD RF EMISSION MEASUREMENTS REFERENCE AND PLANE	13
O CVCTEM VALIDATION	4.4
8 SYSTEM VALIDATION	
8.1 VALIDATION PROCEDURE	
8.2 VALIDATION RESULT	14
9 EVALUATION OF MIF	15
9.1 Introduction	
9.2 MIF MEASUREMENT WITH THE AIA	
9.3 TEST EQUIPMENT FOR THE MIF MEASUREMENT	
9.4 TEST SIGNAL VALIDATION	
10 EVALUATION FOR LOW-POWER EXEMPTION	19
10.1 PRODUCT TESTING THRESHOLD	
10.2 CONDUCTED POWER	19



10.3 CONCLUSION	19
11 RF TEST PROCEDUERES	20
12 MEASUREMENT RESULTS (E-FIELD)	21
13 ANSIC 63.19-2011 LIMITS	21
14 MEASUREMENT UNCERTAINTY	22
15 MAIN TEST INSTRUMENTS	23
16 CONCLUSION	23
ANNEX A TEST LAYOUT	24
ANNEX B TEST PLOTS	25
ANNEX C SYSTEM VALIDATION RESULT	31
ANNEX D PROBE CALIBRATION CERTIFICATE	33
ANNEX E DIPOLE CALIBRATION CERTIFICATE	43



# 1 Test Laboratory

### 1.1 Testing Location

CompanyName:	CTTL(Shouxiang)
Address:	No. 51 Shouxiang Science Building, Xueyuan Road, Haidian District,
	Beijing, P. R. China100191

### 1.2 Testing Environment

Temperature:	18°C~25°C,		
Relative humidity:	30%~ 70%		
Ground system resistance: $< 0.5 \Omega$			
Ambient noise is checked and found very low and in compliance with requirement of standards			

Ambient noise is checked and found very low and in compliance with requirement of standards. Reflection of surrounding objects is minimized and in compliance with requirement of standards.

### 1.3 Project Data

Project Leader:	Qi Dianyuan
Test Engineer:	Lin Hao
Testing Start Date:	December 20, 2016
Testing End Date:	December 20, 2016

### 1.4 Signature

Lin Xiaojun

(Prepared this test report)

Qi Dianyuan

(Reviewed this test report)

Lu Bingsong

**Deputy Director of the laboratory** 

(Approved this test report)



# **2 Client Information**

# 2.1 Applicant Information

Company Name:	TCL Communication Ltd.
Address /Dest	5F, C building, No. 232, Liang Jing Road ZhangJiang High-Tech Park,
Address /Post:	Pudong Area Shanghai, P.R. China. 201203
City:	Shanghai
Postal Code:	201203
Country:	P.R.China
Contact:	Gong Zhizhou
Email:	zhizhou.gong@tcl.com
Telephone:	0086-21- 31363544
Fax:	0086-21-61460602

# 2.2 Manufacturer Information

Company Name:	TCL Communication Ltd.
Address /Dest	5F, C building, No. 232, Liang Jing Road ZhangJiang High-Tech Park,
Address /Post:	Pudong Area Shanghai, P.R. China. 201203
City:	Shanghai
Postal Code:	201203
Country:	P.R.China
Contact:	Gong Zhizhou
Email:	zhizhou.gong@tcl.com
Telephone:	0086-21- 31363544
Fax:	0086-21-61460602



# 3 Equipment Under Test (EUT) and Ancillary Equipment (AE)

#### 3.1 About EUT

Description:	LTE / UMTS / GSM mobile phone		
Model name:	5044O		
Operating mode(s):	GSM 850/900/1800/1900, WCDMA 850/900/1700/1900/2100		
	BT, Wi-Fi, LTE Band 1/2/3/4/7/12/13/17/28		

### 3.2 Internal Identification of EUT used during the test

EUT ID*	IMEI	HW Version	SW Version
EUT1	1	PIO	v4HA2
EUT2	1	PIO	v4HA2

<sup>\*</sup>EUT ID: is used to identify the test sample in the lab internally.

**Note:** It is performed to test HACwith the EUT1 and conducted power with the EUT2.

#### 3.3 Internal Identification of AE used during the test

AE ID*	Description	Model		Manufacturer
AE1	Battery	CAB2000070C1	1	BYD
AE2	Battery	CAB2000071C7	1	VEKEN

<sup>\*</sup>AE ID: is used to identify the test sample in the lab internally.

Note: It is performed to test HAC with the AE2.

### 3.4 Air Interfaces / Bands Indicating Operating Modes

Air-interface	Band(MHz)	Туре	C63.19/tested	Simultaneous Transmissions	отт	Power Reduction
GSM	850	VO	Yes	BT, WLAN	NA	NA
GSIVI	1900	VO				
GPRS/EDGE	850	DT	NA			No
GPRS/EDGE	1900	וטן				
MCDMA	850	1/0	Yes	BT, WLAN	NA	NA
WCDMA (UMTS)	1900	VO				
	HSPA	DT	NA			
LTE	Band 2/4/7/12/13/17	V/D.	NA	BT, WLAN	NA	NA
BT	2450	DT	NA	GSM, WCDMA, LTE	NA	NA
WLAN	2450	DT	NA	GSM, WCDMA, LTE	NA	NA

VO: Voice CMRS/PSTN Service Only

V/D: Voice CMRS/PSTN and Data Service DT: Digital Transport

Note:1.= No Associated T-Coil measurement has been made in accordance with 285076 D02 T-Coil testing for CMRS IP

<sup>\*</sup> HAC Rating was not based on concurrent voice and data modes, Non current mode was found to represent worst case rating for both M and T rating



### **4 CONDUCTED OUTPUT POWER MEASUREMENT**

This EUT is a variant product and the report of original sample is No.I16Z42271-SEM02 .According to the client request, we quote the test results of original sample directly

#### 4.1 Summary

During the process of testing, the EUT was controlled via Agilent Digital Radio Communication tester (E5515C) to ensure the maximum power transmission and proper modulation. This result contains conducted output power for the EUT. In all cases, the measured output power should be greater and within 5% than EMI measurement.

#### **4.2 Conducted Power**

GSM		Conducted Power (dBm)			
850MHz	Channel 251(848.8MHz)	Channel 190(836.6MHz)	Channel 128(824.2MHz)		
OSUMINZ	32.35	32.43	32.45		
GSM	Conducted Power(dBm)				
1900MHz	Channel 810(1909.8MHz)	Channel 661(1880MHz)	Channel 512(1850.2MHz)		
1900141712	29.16	29.21	29.30		
WCDMA		Conducted Power (dBm)			
850MHz	Channel 4233(846.6MHz)	Channel 4182(836.4MHz)	Channel 4132(826.4MHz)		
030141112	22.82	22.89	22.93		
WCDMA		Conducted Power (dBm)			
1900MHz	Channel 9538(1907.6MHz)	Channel 9400(1880MHz)	Channel 9262(1852.4MHz)		
130011112	23.52	23.66	23.56		
LTE	Conducted Power (dBm)				
Band2	Channel 19100(1900MHz)	Channel18900(1880MHz)	Channel 18700(1860MHz)		
QPSK	23.74	23.81	23.81		
LTE		Conducted Power (dBm)			
Band4	Channel 20300(1745MHz)	Channel20175(1732.5MHz)	Channel 20050(1720MHz)		
QPSK	23.62	23.65	23.55		
LTE		Conducted Power (dBm)			
Band7	Channel 21350(2560MHz)	Channel21100(2535MHz)	Channel 20850(2510MHz)		
QPSK	21.72	21.77	21.45		
LTE		Conducted Power (dBm)			
Band12	Channel 23130(711MHz)	Channel 23095(707.5MHz)	Channel23060(704MHz)		
QPSK	23.54	23.49	23.58		
LTE	Conducted Power (dBm)				
Band13	Channel 23230(782MHz)				
QPSK	23.52				
LTE	Conducted Power (dBm)				
Band17	Channel 23800(711MHz)	Channel 23790(710MHz)	Channel 23780(709MHz)		
QPSK	23.43	23.39	23.55		
LTE		Conducted Power (dBm)			



Band2	Channel 19100(1900MHz)	Channel18900(1880MHz)	Channel 18700(1860MHz)	
16-QAM	22.86	22.95	22.93	
LTE		Conducted Power (dBm)		
Band4	Channel 20300(1745MHz)	Channel20175(1732.5MHz)	Channel 20050(1720MHz)	
16-QAM	22.97	22.85	22.99	
LTE		Conducted Power (dBm)		
Band7	Channel 21350(2560MHz)	Channel21100(2535MHz)	Channel 20850(2510MHz)	
16-QAM	21.21	20.92	20.94	
LTE		Conducted Power (dBm)		
Band12	Channel 23130(711MHz)	Channel 23095(707.5MHz)	Channel23060(704MHz)	
16-QAM	22.43	22.57	22.49	
LTE		Conducted Power (dBm)		
Band13		Channel 23230(782MHz)		
16-QAM	22.65			
LTE	Conducted Power (dBm)			
Band17	Channel 23800(711MHz)	Channel 23790(710MHz)	Channel 23780(709MHz)	
16-QAM	22.30	22.43	22.40	

# **5 Reference Documents**

# 5.1 Reference Documents for testing

The following document listed in this section is referred for testing.

Reference	Title	Version	
ANSI C63.19-2011	American National Standard forMethods of Measurement	2011	
	ofCompatibility between WirelessCommunication Devices	Edition	
	andHearing Aids		
FCC 47 CFR §20.19	Hearing Aid Compatible Mobile Headsets		
		Edition	
KDB 285076 D01	Equipment Authorization Guidance for Hearing Aid	v04	
	Compatibility		



#### **60PERATIONAL CONDITIONS DURING TEST**

#### 6.1 HAC MEASUREMENT SET-UP

These measurements are performed using the DASY5 NEO automated dosimetric assessment system. It is made by Schmid & Partner Engineering AG (SPEAG) in Zurich, Switzerland. It consists ofhigh precision robotics system (Stäubli), robot controller, Intel Core2 computer, near-fieldprobe, probe alignment sensor. The robot is a six-axis industrial robot performing precise movements. A cell controller system contains the power supply, robot controller, teach pendant (Joystick), and remote control, is used to drive the robot motors. The PC consists of the HP Intel Core21.86 GHz computer with Windows XP system and HAC Measurement Software DASY5 NEO, A/Dinterface card, monitor, mouse, and keyboard. The Stäubli Robot is connected to the cellcontroller to allow software manipulation of the robot. A data acquisition electronic (DAE)circuit performs the signal amplification, signal multiplexing, AD-conversion, offsetmeasurements, mechanical surface detection, collision detection, etc. is connected to the Electro-optical coupler (EOC). The EOC performs the conversion from the optical into digitalelectric signal of the DAE and transfers data to the PC plug-in card.

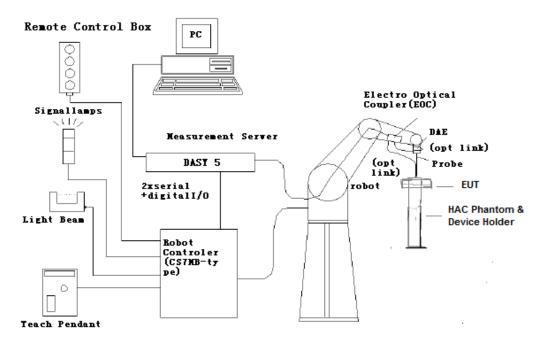


Fig. 1 HAC Test Measurement Set-up

The DAE4 consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, achannel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoderand control logic unit. Transmission to the PC-card is accomplished through an optical downlink for data and status information and an optical uplink for commands and clock lines. The mechanical probe mounting device includes two different sensor systems for frontal and sidewise probe contacts. They are also used for mechanical surface detection and probecollision detection. The robot uses its own controller with a built in VME-bus computer.



### 6.2 Probe Specification

#### E-Field Probe Description

Construction One dipole parallel, two dipoles normal to probe axis

Built-in shielding against static charges

PEEK enclosure material

Calibration In air from 100 MHz to 3.0 GHz (absolute accuracy ±6.0%,

k=2)

Frequency 40 MHz to > 6 GHz (can be extended to < 20 MHz)

Linearity: ± 0.2 dB (100 MHz to 3 GHz)

Directivity  $\pm 0.2$  dB in air (rotation around probe axis)

± 0.4 dB in air (rotation normal to probe axis)

DynamicRange 2 V/m to > 1000 V/m; Linearity: ± 0.2 dB

Dimensions Overall length: 330 mm (Tip: 16 mm)

Tip diameter: 8 mm (Body: 12 mm)

Distance from probe tip to dipole centers: 2.5 mm

Application General near-field measurements up to 6 GHz

Field component measurements

Fast automatic scanning in phantoms



[ER3DV6]



#### 6.3Test Arch Phantom & Phone Positioner

The Test Arch phantom should be positioned horizontally on a stable surface. Reference markings on the Phantom allow the complete setup of all predefined phantom positions and measurement grids by manually teaching three points in the robot. It enables easy and well defined positioning of the phone and validation dipoles as well as simple teaching of the robot (Dimensions:  $370 \times 370 \times 370 \text{ mm}$ ).

The Phone Positioner supports accurate and reliable positioning of any phone with effect on near field  $<\pm 0.5$  dB.

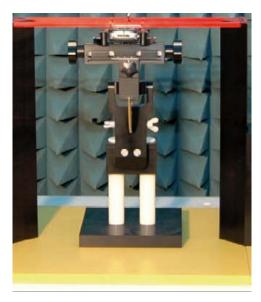


Fig. 2 HAC Phantom & Device Holder

#### 6.4Robotic System Specifications

#### **Specifications**

Positioner: Stäubli Unimation Corp. Robot Model: RX160L

Repeatability: ±0.02 mm

No. of Axis: 6

### **Data Acquisition Electronic (DAE) System**

**Cell Controller** 

Processor:Intel Core2 Clock Speed: 1.86GHz

**Operating System: Windows XP** 

**Data Converter** 

Features: Signal Amplifier, multiplexer, A/D converter, and control logic

Software: DASY5 software

Connecting Lines: Optical downlink for data and status info.

Optical uplink for commands and clock



#### **7EUT ARRANGEMENT**

#### 7.1 WD RF Emission Measurements Reference and Plane

Figure 4 illustrates the references and reference plane that shall be used in the WD emissionsmeasurement.

- The grid is 5 cm by 5 cm area that is divided into 9 evenly sized blocks or sub-grids.
- The grid is centered on the audio frequency output transducer of the WD (speaker or T-coil).
- The grid is located byreference to a reference plane. This reference plane is the planar areathat contains the highest point in thearea of the WD that normally rests against the user's ear
- The measurement plane is located parallel to thereference plane and 15 mm from it, out from the phone. The grid is located in the measurement plane.

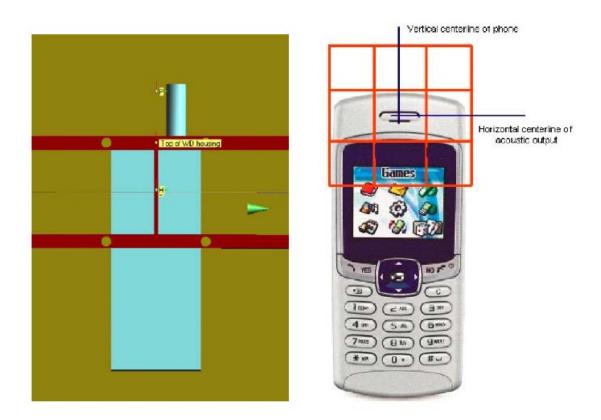


Fig. 3 WD reference and plane for RF emission measurements



#### **8SYSTEM VALIDATION**

#### 8.1 Validation Procedure

Place a dipole antenna meeting the requirements given in ANSI C63.19 in the position normally occupied bythe WD. The dipole antenna serves as a known source for an electrical output. Position the E-field probes so that:

- •The probes and their cables are parallel to the coaxial feed of the dipole antenna
- •The probe cables and the coaxial feed of the dipole antenna approach the measurement area from oppositedirections
- The center point of the probe element(s) are 15 mm from the closest surface of the dipoleelements.

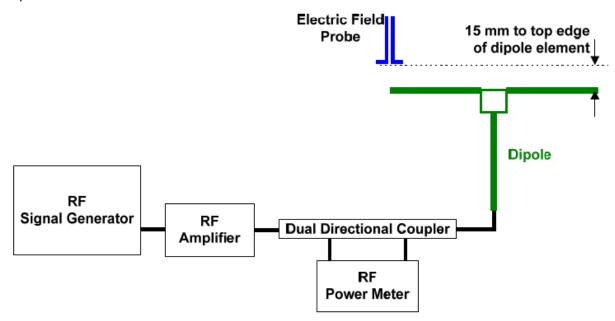


Fig. 4 Dipole Validation Setup

#### 8.2 Validation Result

	E-Field Scan					
Mode	Mode Frequency Input Power Measured <sup>1</sup> Target <sup>2</sup> Deviation <sup>3</sup> Limit <sup>4</sup>					
	(MHz)	(mW)	Value(dBV/m)	Value(dBV/m)	(%)	(%)
CW	835	100	40.72	40.54	2.09	±25
CW	1880	100	39.39	39.35	0.46	±25

#### Notes:

- 1. Please refer to the attachment for detailed measurement data and plot.
- 2. Target value is provided by SPEAD in the calibration certificate of specific dipoles.
- 3. Deviation (%) = 100 \* (Measured value minus Target value) divided by Target value.
- 4. ANSI C63.19 requires values within  $\pm$  25% are acceptable, of which 12% is deviation and 13% is measurement uncertainty. Values independently validated for the dipole actually used in the measurements should be used, when available.



### 9Evaluation of MIF

#### 9.1 Introduction

The MIF (Modulation Interference Factor) is used to classify E-field emission to determine HearingAid Compatibility (HAC). It scales the power-averaged signal to the RF audio interference level and characteristic to a modulation scheme. The HAC standard preferred "indirect" measurementmethod is based on average field measurement with separate scaling by the MIF. Withan Audio Interference Analyzer (AIA) designed by SPEAG specifically for the MIF measurement, these values have been verified by practical measurements on an RF signal modulated with eachof the waveforms. The resulting deviations from the simulated values are within the requirements of the HAC standard.

The AIA (Audio Interference Analyzer) is an USB powered electronic sensor to evaluate signals in the frequency range 698MHz - 6 GHz. It contains RMS detector and audio frequency circuits for sampling of the RFenvelope.

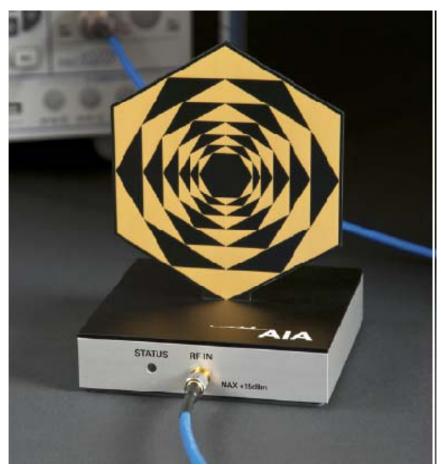


Fig. 5 AIA Front View



#### 9.2MIF measurement with the AIA

The MIF is measured with the AIA as follows:

- 1. Connect the AIA via USB to the DASY5 PC and verify the configuration settings.
- 2. Couple the RF signal to be evaluated to an AIA via cable or antenna.
- 3. Generate a MIF measurement job for the unknown signal and select the measurement port and timing settings.
- 4. Document the results via the post processor in a report.

#### 9.3Test equipment for the MIF measurement

No.	Name	Туре	Serial Number	Manufacturer
01	Signal Generator	E4438C	MY49071430	Agilent
02	AIA	SE UMS 170 CB	1029	SPEAG
03	BTS	E5515C	MY50263375	Agilent

### 9.4 Test signal validation

The signal generator (E4438C) is used to generate a 1GHz signal with different modulation in the below table based on the ANSI C63.19-2011. The measured MIF with AIA are compared with the target values given in ANSI C63.19-2011 table D.3, D.4 and D5.

Pulse modulation	Target MIF	Measured MIF	Deviation
0.5ms pulse, 1000Hz repetition rate	-0.9 dB	-0.9 dB	0 dB
1ms pulse, 100Hz repetition rate	+3.9 dB	+3.7 dB	0.2 dB
0.1ms pulse, 100Hz repetition rate	+10.1 dB	+10.0 dB	0.1 dB
10ms pulse, 10Hz repetition rate	+1.6 dB	+1.7 dB	0.1 dB
Sine-wave modulation	Target MIF	Measured MIF	Deviation
1 kHz, 80% AM	-1.2 dB	-1.3 dB	0.1 dB
1 kHz, 10% AM	-9.1 dB	-9.0 dB	0.1 dB
1 kHz, 1% AM	-19.1 dB	-18.9 dB	0.2 dB
100 Hz, 10% AM	-16.1 dB	-16.0 dB	0.1 dB
10 kHz, 10% AM	-21.5 dB	-21.6 dB	0.1 dB
Transmission protocol	Target MIF	Measured MIF	Deviation
GSM; full-rate version 2; speech codec/handset low	+3.5 dB	+3.47 dB	0.03 dB
WCDMA; speech; speech codec low; AMR 12.2 kb/s	-20.0 dB	-19.8 dB	0.2 dB
CDMA; speech; SO3; RC3; full frame rate; 8kEVRC	-19.0 dB	-19.1 dB	0.1 dB
CDMA; speech; SO3; RC1; 1/8 <sup>th</sup> frame rate; 8kEVRC	+3.3 dB	+3.44 dB	0.14 dB



# 9.5 DUTMIF results

Typical MIF levels in ANSI C63.19-2011			
Transmission protocol Modulation interference fa			
GSM; full-rate version 2; speech codec/handset low	+3.5 dB		
WCDMA; speech; speech codec low; AMR 12.2 kb/s	-20.0 dB		
LTE-FDD (SC-FDMA, 1RB, 20MHz, QPSK)	-15.63 dB		
LTE-FDD (SC-FDMA, 1RB, 20MHz, QPSK)	-9.76 dB		

Measured MIF levels				
Band	Channel	Modulation interference factor		
	251	+3.46 dB		
GSM 850	190	+3.45 dB		
	128	+3.42 dB		
	810	+3.43 dB		
GSM 1900	661	+3.49 dB		
	512	+3.51 dB		
	4233	-19.61 dB		
WCDMA 850	4182	-19.64 dB		
	4132	-19.65 dB		
	9538	-19.75 dB		
WCDMA 1900	9400	-19.73 dB		
	9262	-19.76 dB		
	19100	-14.22db		
LTE Band2 ————————————————————————————————————	18900	-14.56db		
QI OIX	18700	-14.72db		
	20300	-14.47db		
LTE Band4  QPSK	20175	-15.15db		
QI OIX	20050	-15.06db		
	21350	-14.19db		
LTE Band7  QPSK	21100	-14.60db		
Qi Sit	20850	-14.12db		
	23130	-14.39db		
LTE Band12 — QPSK —	23095	-14.14db		
QI OIV	23060	-14.66db		
LTE Band13 QPSK	23230	-14.41db		
	23800	-14.32 db		
LTE Band17  QPSK	23790	-14.13 db		
Qi Oit	23780	-14.40 db		

LTE Band2	19100	-9.25db
16QAM	18900	-10.72db



# No.I16Z42280-SEM03 Page18of59

	18700	-10.34db
LTE D	20300	-10.08db
LTE Band4 16QAM	20175	-9.96db
1000/1101	20050	-10.73db
LTC D	21350	-10.76db
LTE Band7 16QAM	21100	-10.25db
1000/1101	20850	-10.29db
LTE D	23130	-10.70db
LTE Band12 16QAM	23095	-9.12db
100/1101	23060	-10.07db
LTE Band13 16QAM	23230	-10.38db
1.TE D 14.7	23800	-10.58 db
LTE Band17 16QAM	23790	-9.79 db
100/1101	23780	-10.15 db



### 10 Evaluation for low-power exemption

### 10.1 Product testing threshold

There are two methods for exempting an RF air interface technology from testing. The first methodrequires evaluation of the MIF for the worst-case operating mode. An RF air interfacetechnology of a device is exempt from testing when its average antenna input power plus its MIF is  $\leq$  17 dBm for any of its operating modes. The second method does not require determination of the MIF. The RF emissions testing exemption shall be applied to an RF air interface technology in a device whose peak antenna input power, averaged over intervals  $\leq$  50  $\mu$  s20, is  $\leq$  23 dBm. An RF air interface technology that is exempted from testing by either method shall be rated as M4.

The first method is used to be exempt from testing for the RF air interface technology in this report.

### 10.2 Conducted power

Band	Average power (dBm)	MIF (dB)	Sum (dBm)
GSM 850	32.45	3.46	35.91
GSM 1900	29.3	3.51	32.81
WCDMA 850	22.93	-19.61	3.32
WCDMA 1900	23.66	-19.73	3.93
LTE Band2 QPSK	23.81	-14.22	9.59
LTE Band4 QPSK	23.65	-14.47	9.18
LTE Band7 QPSK	21.77	-14.12	7.65
LTE Band12 QPSK	23.58	-14.14	9.44
LTE Band13 QPSK	23.52	-14.41	9.11
LTE Band17 QPSK	23.55	-14.13	9.42
LTE Band2 16QAM	22.95	-9.25	13.7
LTE Band4 16QAM	22.99	-9.96	13.03
LTE Band7 16QAM	21.21	-10.25	10.96
LTE Band12 16QAM	22.57	-9.12	13.45
LTE Band13 16QAM	22.65	-10.38	12.27
LTE Band17 16QAM	22.43	-9.79	12.64

#### 10.3 Conclusion

According to the above table, the sums of average power and MIF for UMTS and LTE are less than 17dBm. So it is only measured for GSM bands. The UMTS and LTE bands are exempt from testing and rated as M4.



#### 11 RF TEST PROCEDUERES

### The evaluation was performed with the following procedure:

- 1) Confirm proper operation of the field probe, probe measurement system and otherinstrumentation and the positioning system.
- 2) Position the WD in its intended test position. The gauge block can simplifythis positioning.
- 3) Configure the WD normal operation for maximum rated RF output power, at the desired channel and other operating parameters (e.g., test mode), as intended for the test.
- 4) The center sub-grid shall centered on the center of the T-Coil mode axial measurement point orthe acoustic output, as appropriate. Locate the field probe at the initial test position in the 50 mm by 50 mm grid, which is contained in the measurement plane. If the field alignment method is used, align the probe for maximumfield reception.
- 5) Record the reading.
- 6) Scan the entire 50 mm by 50 mm region in equally spaced increments and record the reading ateach measurement point. The distance between measurement points shall be sufficient to assure the identification of the maximum reading.
- 7) Identify the five contiguous sub-grids around the center sub-grid whose maximum reading is the lowest of all available choices. This eliminates the three sub-grids with the maximum readings. Thus, the six areas to be used to determine the WD's highest emissions are identified.
- 8) Identify the maximum field reading within the non-excluded sub-grids identified in Step 7)
- 9) Evaluate the MIF and add to the maximum steady-state rms field-strength reading to obtain the RF audio interference level..
- Compare this RF audio interference level with the categories and record the resulting WD category rating.



# 12Measurement Results (E-Field)

Fred	quency	Measured	Measured Power Prift (dR)	
MHz	Channel	Value(dBV/m)	Power Drift (dB)	Category
	•	GSM 8	50	
848.8	251	37.45	0.01	<b>M4</b> (see Fig B.1)
836.6	190	36.57	-0.01	<b>M4</b> (see Fig B.2)
824.2	128	35.66	-0.04	<b>M4</b> (see Fig B.3)
	•	GSM 19	000	
1909.8	810	29.92	0.13	<b>M4</b> (see Fig B.4)
1880	661	30.11	0.02	M3 (see Fig B.5)
1850.2	512	30.11	-0.08	M3(see Fig B.6)

# 13ANSIC 63.19-2011 LIMITS

# WD RF audio interference level categories in logarithmic units

Emission categories	< 960 MHz		
	E-field emissions		
Category M1	50 to 55	dB (V/m)	
Category M2	45 to 50	dB (V/m)	
Category M3	40 to 45	dB (V/m)	
Category M4	< 40	dB (V/m)	
Emission categories	>960	MHz	
	E-field e	missions	
Category M1	40 to 45	dB (V/m)	
Category M2	35 to 40	dB (V/m)	
Category M3	30 to 35	dB (V/m)	
Category M4	< 30	dB (V/m)	



# **14 MEASUREMENT UNCERTAINTY**

No.	Error source	Type	Uncertainty Value(%)	Prob. Dist.	k	c <sub>i</sub> E	Standard Uncertainty (%) $u_i^{'}$ (%)E	Degree of freedom V <sub>eff</sub> or <i>v</i> <sub>i</sub>
	surement System	-		l			F.4	
1	Probe Calibration	В	5.	N	1	1	5.1	∞
2	Axial Isotropy	В	4.7	R	$\sqrt{3}$	1	2.7	∞
3	Sensor Displacement	В	16.5	R	$\sqrt{3}$	1	9.5	∞
4	Boundary Effects	В	2.4	R	$\sqrt{3}$	1	1.4	∞
5	Linearity	В	4.7	R	$\sqrt{3}$	1	2.7	∞
6	Scaling to Peak Envelope Power	В	2.0	R	$\sqrt{3}$	1	1.2	∞
7	System Detection Limit	В	1.0	R	$\sqrt{3}$	1	0.6	∞
8	Readout Electronics	В	0.3	N	1	1	0.3	∞
9	Response Time	В	0.8	R	$\sqrt{3}$	1	0.5	∞
10	Integration Time	В	2.6	R	$\sqrt{3}$	1	1.5	∞
11	RF Ambient Conditions	В	3.0	R	$\sqrt{3}$	1	1.7	<b>∞</b>
12	RF Reflections	В	12.0	R	$\sqrt{3}$	1	6.9	∞
13	Probe Positioner	В	1.2	R	$\sqrt{3}$	1	0.7	∞
14	Probe Positioning	Α	4.7	R	$\sqrt{3}$	1	2.7	∞
15	Extra. And Interpolation	В	1.0	R	$\sqrt{3}$	1	0.6	∞
Test	Test Sample Related							
16	Device Positioning Vertical	В	4.7	R	$\sqrt{3}$	1	2.7	<b>∞</b>
17	Device Positioning Lateral	В	1.0	R	$\sqrt{3}$	1	0.6	∞
18	Device Holder and Phantom	В	2.4	R	$\sqrt{3}$	1	1.4	∞
19	Power Drift	В	5.0	R	$\sqrt{3}$	1	2.9	∞



20	AIA measurement	В	12	R	$\sqrt{3}$	1	6.9	∞
Pha	Phantom and Setup related							
21	Phantom Thickness	В	2.4	R	$\sqrt{3}$	1	1.4	∞
Com	Combined standard uncertainty(%) 16.2							
-	nded uncertainty idence interval of 95 %)	ı	$u_e = 2u_c$	N	k=:	2	32.4	

# **15 MAIN TEST INSTRUMENTS**

**Table 1: List of Main Instruments** 

No.	Name	Туре	Serial Number	Calibration Date	Valid Period
01	Signal Generator	E4438C	MY49071430	February 01,2016	One Year
02	Power meter	NRVD	102196	Marah02 2016	One year
03	Power sensor	NRV-Z5	100596	March03,2016	One year
04	Amplifier	60S1G4	0331848	No Calibration Re	quested
05	E-Field Probe	ER3DV6	2272	January19, 2016	One year
06	HAC Dipole	CD835V3	1023	August31, 2016	One year
07	HAC Dipole	CD1880V3	1018	August31, 2016	One year
08	BTS	E5515C	MY50263375	January 30, 2016	One year
09	DAE	SPEAG DAE4	777	August26, 2016	One year
10	AIA	SE UMS 170 CB	1029	No Calibration Re	quested

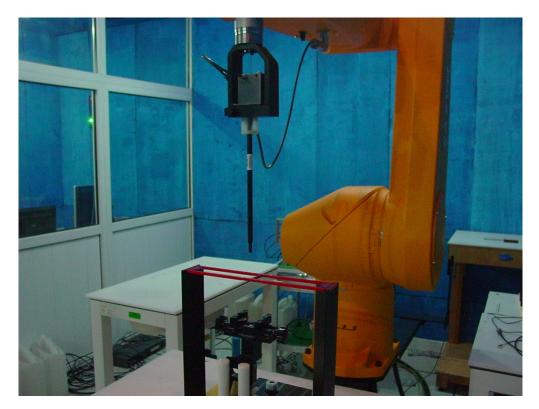
### **16 CONCLUSION**

The HAC measurement indicates that the EUT complies with the HAC limits of the ANSIC63.19-2011. The total M-rating is **M3.** 

\*\*\*END OF REPORT BODY\*\*\*



# **ANNEX A TEST LAYOUT**



Picture A1:HAC RF System Layout



### **ANNEX BTEST PLOTS**

### HAC RF E-Field GSM 850 High

Date: 2016-12-20

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used:  $\sigma = 0$  mho/m,  $\varepsilon_r = 1$ ;  $\rho = 1000$  kg/m<sup>3</sup>

Ambient Temperature:22.3°C

Communication System: GSM 850; Frequency: 848.8 MHz; Duty Cycle: 1:8.3

Probe: ER3DV6 - SN2272;ConvF(1, 1, 1)

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device/Hearing Aid

Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 62.24 V/m; Power Drift = 0.01 dB

Applied MIF = 3.46 dB

RF audio interference level = 37.45 dBV/m

**Emission category: M4** 

Grid 1 <b>M4</b>	Grid 2 <b>M4</b>	Grid 3 <b>M4</b>
37.6 dBV/m	37.7 dBV/m	37 dBV/m
Grid 4 <b>M4</b>	Grid 5 M4	Grid 6 <b>M4</b>
37.29 dBV/m	37.45 dBV/m	36.89 dBV/m
Grid 7 <b>M4</b>	Grid 8 <b>M4</b>	Grid 9 <b>M4</b>
36.8 dBV/m	36.97 dBV/m	36.22 dBV/m

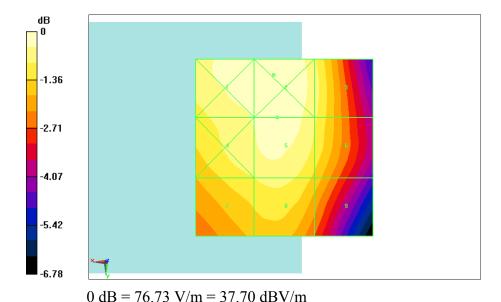


Fig B.1 HAC RF E-Field GSM 850 High



#### HAC RF E-Field GSM 850 Middle

Date: 2016-12-20

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used:  $\sigma = 0$  mho/m,  $\varepsilon_r = 1$ ;  $\rho = 1000$  kg/m<sup>3</sup>

Ambient Temperature:22.3°C

Communication System: GSM 850; Frequency: 836.6 MHz; Duty Cycle: 1:8.3

Probe: ER3DV6 - SN2272;ConvF(1, 1, 1)

# E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device 2/Hearing Aid

Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 57.33 V/m; Power Drift = -0.01 dB

Applied MIF = 3.45 dB

RF audio interference level = 36.57 dBV/m

**Emission category: M4** 

Grid 1 <b>M4</b>	Grid 2 M4	Grid 3 <b>M4</b>
36.82 dBV/m	36.85 dBV/m	35.94 dBV/m
Grid 4 <b>M4</b>	Grid 5 M4	Grid 6 <b>M4</b>
36.5 dBV/m	36.57 dBV/m	35.84 dBV/m
Grid 7 <b>M4</b>	Grid 8 <b>M4</b>	Grid 9 <b>M4</b>
35.87 dBV/m	35.99 dBV/m	35.13 dBV/m

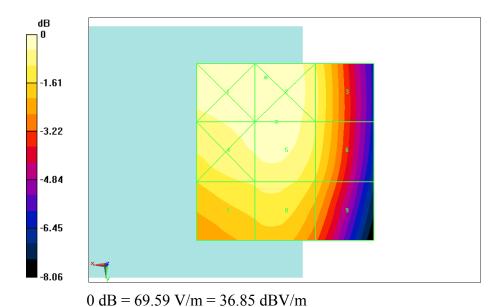


Fig B.2 HAC RF E-Field GSM 850 Middle



#### HAC RF E-Field GSM 850 Low

Date: 2016-12-20

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used:  $\sigma = 0$  mho/m,  $\varepsilon_r = 1$ ;  $\rho = 1000$  kg/m<sup>3</sup>

Ambient Temperature:22.3°C

Communication System: GSM 850; Frequency: 824.2 MHz; Duty Cycle: 1:8.3

Probe: ER3DV6 - SN2272;ConvF(1, 1, 1)

# E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device 3/Hearing Aid

Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

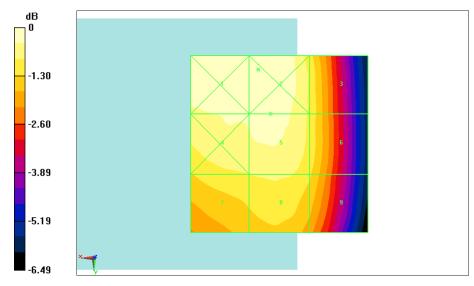
Reference Value = 51.46 V/m; Power Drift = -0.04 dB

Applied MIF = 3.42 dB

RF audio interference level = 35.66 dBV/m

**Emission category: M4** 

Grid 1 <b>M4</b>	Grid 2 <b>M4</b>	Grid 3 <b>M4</b>
35.92 dBV/m	35.95 dBV/m	35.03 dBV/m
Grid 4 <b>M4</b>	Grid 5 M4	Grid 6 <b>M4</b>
35.6 dBV/m	35.66 dBV/m	35 dBV/m
Grid 7 <b>M4</b>	Grid 8 <b>M4</b>	Grid 9 <b>M4</b>
35.09 dBV/m	35.18 dBV/m	34.72 dBV/m



0 dB = 62.73 V/m = 35.95 dBV/m

Fig B.3 HAC RF E-Field GSM 850 Low



### HAC RF E-Field GSM 1900 High

Date: 2016-12-20

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used:  $\sigma = 0$  mho/m,  $\varepsilon_r = 1$ ;  $\rho = 1000$  kg/m<sup>3</sup>

Ambient Temperature:22.3°C

Communication System: DCS 1900; Frequency: 1909.8 MHz; Duty Cycle: 1:8.3

Probe: ER3DV6 - SN2272;ConvF(1, 1, 1)

# E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device/Hearing Aid

Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 9.412 V/m; Power Drift = 0.13 dB

Applied MIF = 3.43 dB

RF audio interference level = 29.92 dBV/m

**Emission category: M4** 

Grid 1 <b>M4</b>	Grid 2 <b>M4</b>	Grid 3 <b>M4</b>
29.53 dBV/m	29.92 dBV/m	29.63 dBV/m
Grid 4 <b>M4</b>	Grid 5 M4	Grid 6 <b>M4</b>
29.78 dBV/m	27.21 dBV/m	25.33 dBV/m
Grid 7 M3	Grid 8 <b>M4</b>	Grid 9 <b>M4</b>
30.17 dBV/m	29.58 dBV/m	28.18 dBV/m

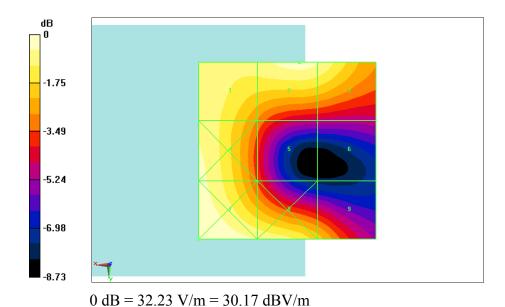


Fig B.4 HAC RF E-Field GSM 1900 High



#### HAC RF E-Field GSM 1900 Middle

Date: 2016-12-20

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used:  $\sigma = 0$  mho/m,  $\varepsilon_r = 1$ ;  $\rho = 1000$  kg/m<sup>3</sup>

Ambient Temperature:22.3°C

Communication System: DCS 1900; Frequency: 1880 MHz; Duty Cycle: 1:8.3

Probe: ER3DV6 - SN2272;ConvF(1, 1, 1)

### E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device 2/Hearing Aid

Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

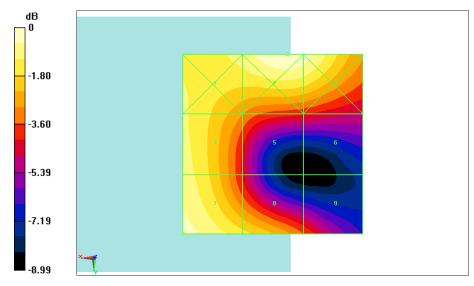
Reference Value = 10.78 V/m; Power Drift = 0.02 dB

Applied MIF = 3.49 dB

RF audio interference level = 30.11 dBV/m

**Emission category: M3** 

Grid 1 <b>M4</b>	Grid 2 M3	Grid 3 M3
29.58 dBV/m	30.46 dBV/m	30.19 dBV/m
Grid 4 <b>M4</b>	Grid 5 M4	Grid 6 M4
29.56 dBV/m	27.52 dBV/m	26.38 dBV/m
Grid 7 M3	Grid 8 <b>M4</b>	Grid 9 <b>M4</b>
30.11 dBV/m	28.92 dBV/m	26.9 dBV/m



0 dB = 33.35 V/m = 30.46 dBV/m

Fig B.5 HAC RF E-Field GSM 1900 Middle



#### HAC RF E-Field GSM 1900 Low

Date: 2016-12-20

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used:  $\sigma = 0$  mho/m,  $\varepsilon_r = 1$ ;  $\rho = 1000$  kg/m<sup>3</sup>

Ambient Temperature:22.3°C

Communication System: DCS 1900; Frequency: 1850.2 MHz; Duty Cycle: 1:8.3

Probe: ER3DV6 - SN2272;ConvF(1, 1, 1)

# E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device 3/Hearing Aid

Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

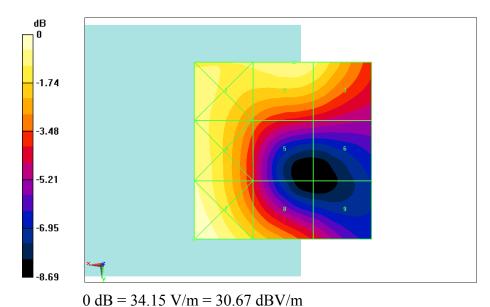
Reference Value = 11.09 V/m; Power Drift = -0.08 dB

Applied MIF = 3.51 dB

RF audio interference level = 30.11 dBV/m

**Emission category: M3** 

Grid 1 M4	Grid 2 M3	Grid 3 <b>M4</b>
29.87 dBV/m	30.11 dBV/m	29.71 dBV/m
Grid 4 M3	Grid 5 M4	Grid 6 <b>M4</b>
30.12 dBV/m	27.69 dBV/m	26.15 dBV/m
Grid 7 M3	Grid 8 <b>M4</b>	Grid 9 <b>M4</b>
30.67 dBV/m	28.92 dBV/m	26.51 dBV/m



0 dD - 34.13 V/III - 30.07 dD V

Fig B.6 HAC RF E-Field GSM 1900 Low



### ANNEX C SYSTEM VALIDATION RESULT

E SCAN of Dipole 835 MHz

Date: 2016-12-20

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used:  $\sigma = 0$  mho/m,  $\varepsilon r = 1$ ;  $\rho = 1000$  kg/m3 Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1

Probe: ER3DV6 - SN2272;ConvF(1, 1, 1)

E Scan - measurement distance from the probe sensor center to CD835 Dipole = 15mm/Hearing Aid Compatibility Test (41x361x1): Interpolated grid: dx=0.5000 mm,

dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

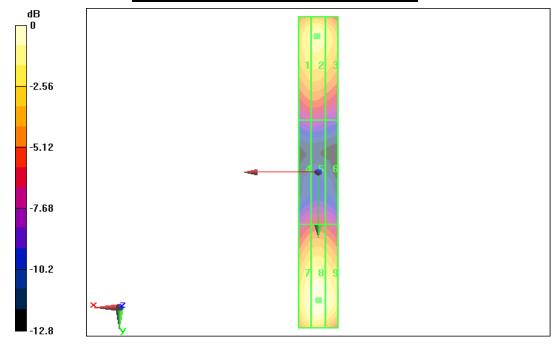
Reference Value = 108.47 V/m; Power Drift = -0.06 dB

Applied MIF = 0.00 dB

RF audio interference level = 40.72 dBV/m

**Emission category: M3** 

Grid 1M3	Grid 2M3	Grid 3M3
40.52 dBV/m	40.72 dBV/m	40.59 dBV/m
Grid 4 <b>M4</b>	Grid 5 M4	Grid 6 <b>M4</b>
35.71 dBV/m	36.02 dBV/m	36.01 dBV/m
Grid 7 <b>M3</b>	Grid 8 <b>M3</b>	Grid 9 <b>M3</b>
40.13 dBV/m	40.43 dBV/m	40.36 dBV/m



0 dB = 40.72 dBV/m



### E SCAN of Dipole 1880 MHz

Date: 2016-12-20

Electronics: DAE4 Sn777

Medium: Air

Medium parameters used:  $\sigma = 0$  mho/m,  $\varepsilon_r = 1$ ;  $\rho = 1000$  kg/m<sup>3</sup>

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1

Probe: ER3DV6 - SN2272;ConvF(1, 1, 1)

E Scan - measurement distance from the probe sensor center to CD1880 Dipole = 15mm/Hearing Aid Compatibility Test (41x181x1): Interpolated grid: dx=0.5000 mm,

dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

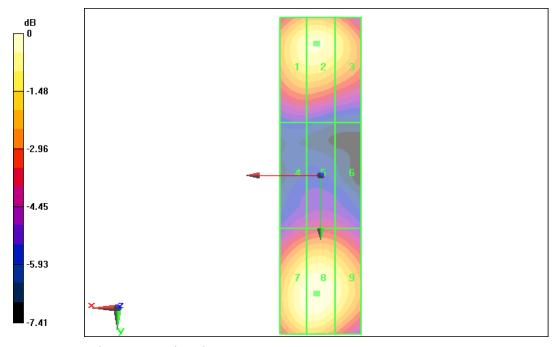
Reference Value = 93.12 V/m; Power Drift = -0.05 dB

Applied MIF = 0.00 dB

RF audio interference level = 39.39 dBV/m

**Emission category: M2** 

Grid 1M2	Grid 2M2	Grid 3M2
39.16 dBV/m	39.39 dBV/m	39.26 dBV/m
Grid 4M2	Grid 5M2	Grid 6M2
36.82 dBV/m	37.01 dBV/m	36.93 dBV/m
Grid 7M2	Grid 8M2	Grid 9 <b>M2</b>
39.19 dBV/m	39.33 dBV/m	39.22 dBV/m



0 dB = 39.39 dBV/m



### ANNEX D PROBE CALIBRATION CERTIFICATE

#### E\_Probe ER3DV6

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Client

CTTL (Auden)

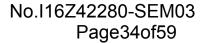
Certificate No: ER3-2272\_Jan16

ER3DV6 - SN:2272
QA CAL-02.v8, QA CAL-25.v6 Calibration procedure for E-field probes optimized for close near field evaluations in air
January 19, 2016
currents the traceability to national standards, which realize the physical units of measurements (SI), incertainties with confidence probability are given on the following pages and are part of the certificate.
nducted in the closed laboratory facility: environment temperature (22 $\pm$ 3)°C and humidity < 70%.

Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	01-Apr-15 (No. 217-02128)	Mar-16
Power sensor E4412A	MY41498087	01-Apr-15 (No. 217-02128)	Mar-16
Reference 3 dB Attenuator	SN: S5054 (3c)	01-Apr-15 (No. 217-02129)	Mar-16
Reference 20 dB Attenuator	SN: S5277 (20x)	01-Apr-15 (No. 217-02132)	Mar-16
Reference 30 dB Attenuator	SN: S5129 (30b)	01-Apr-15 (No. 217-02133)	Mar-16
Reference Probe ER3DV6	SN: 2328	12-Oct-15 (No. ER3-2328_Oct15)	Oct-16
DAE4	SN: 789	16-Mar-15 (No. DAE4-789_Mar15)	Mar-16
Secondary Standards	ID	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642U01700	4-Aug-99 (in house check Apr-13)	In house check: Apr-16
Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-15)	In house check: Oct-16

	Name	Function	Signature
Calibrated by:	Michael Weber	Laboratory Technician	M.Webet
Approved by:	Katja Pokovic	Technical Manager	Selly-
			Issued: January 20, 2016
This calibration certificate	shall not be reproduced except in full	without written approval of the laboratory	

Page 1 of 10 Certificate No: ER3-2272\_Jan16





Calibration Laboratory of Schmid & Partner **Engineering AG** Zeughausstrasse 43, 8004 Zurich, Switzerland





Schweizerischer Kalibrierdienst S Service suisse d'étalonnage Servizio svizzero di taratura **Swiss Calibration Service** 

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Glossary:

NORMx,y,z sensitivity in free space DCP diode compression point

CF crest factor (1/duty\_cycle) of the RF signal A, B, C, D modulation dependent linearization parameters

Polarization o φ rotation around probe axis

9 rotation around an axis that is in the plane normal to probe axis (at measurement center), Polarization 9

i.e., 9 = 0 is normal to probe axis

Connector Angle information used in DASY system to align probe sensor X to the robot coordinate system

#### Calibration is Performed According to the Following Standards:

IEEE Std 1309-2005, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005

b) CTIA Test Plan for Hearing Aid Compatibility, Rev 3.0, November 2013

#### Methods Applied and Interpretation of Parameters:

- NORMx, y, z: Assessed for E-field polarization  $\vartheta = 0$  for XY sensors and  $\vartheta = 90$  for Z sensor (f  $\le 900$  MHz in TEM-cell; f > 1800 MHz: R22 waveguide).
- NORM(f)x,y,z = NORMx,y,z \* frequency\_response (see Frequency Response Chart).
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal
- Ax,y,z; Bx,y,z; Cx,y,z; Dx,y,z; VRx,y,z: A, B, C, D are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode
- Spherical isotropy (3D deviation from isotropy): in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the NORMx (no uncertainty required).

Certificate No: ER3-2272\_Jan16

Page 2 of 10



ER3DV6 - SN:2272

January 19, 2016

# Probe ER3DV6

SN:2272

Manufactured: Calibrated: November 29, 2001 January 19, 2016

Calibrated for DASY/EASY Systems (Note: non-compatible with DASY2 system!)

Certificate No: ER3-2272\_Jan16

Page 3 of 10



ER3DV6 - SN:2272

January 19, 2016

# DASY/EASY - Parameters of Probe: ER3DV6 - SN:2272

**Basic Calibration Parameters** 

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)	
Norm (µV/(V/m) <sup>2</sup> )	1.66	1.66 1.71		± 10.1 %	
DCP (mV) <sup>8</sup>	100.4	99.4	100.7		

**Modulation Calibration Parameters** 

UID	Communication System Name		A dB	B dB√μV	С	D dB	VR mV	Unc <sup>E</sup> (k=2)
0	CW	X	0.0	0.0	1.0	0.00	198.9	±3.8 %
	2.0	Y	0.0	0.0	1.0		165.5	
		Z	0.0	0.0	1.0		196.7	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

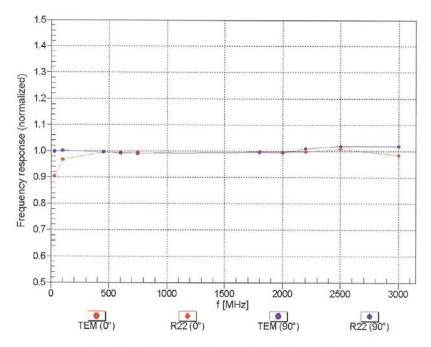
Certificate No: ER3-2272\_Jan16

B Numerical linearization parameter: uncertainty not required. E Uncertainty is determined using the max, deviation from linear response applying rectangular distribution and is expressed for the square of the field value.



ER3DV6 - SN:2272 January 19, 2016

# Frequency Response of E-Field (TEM-Cell:ifi110 EXX, Waveguide: R22)



Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)

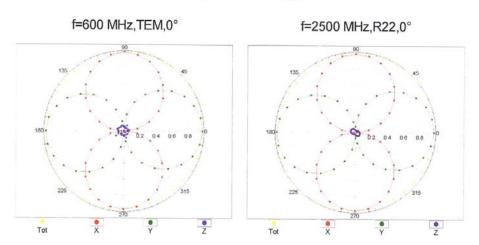
Certificate No: ER3-2272\_Jan16

Page 5 of 10

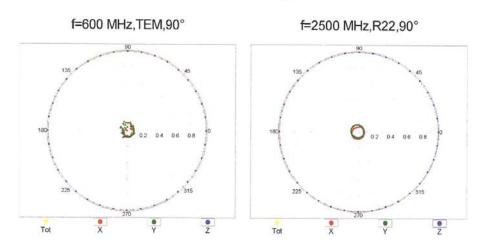


ER3DV6 – SN:2272 January 19, 2016

## Receiving Pattern ( $\phi$ ), $\vartheta = 0^{\circ}$



## Receiving Pattern ( $\phi$ ), $9 = 90^{\circ}$

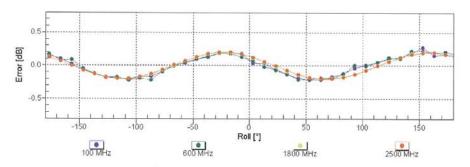


Certificate No: ER3-2272\_Jan16 Page 6 of 10



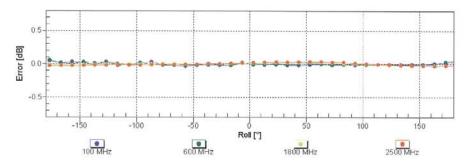
ER3DV6 – SN:2272 January 19, 2016

## Receiving Pattern ( $\phi$ ), $\vartheta = 0^{\circ}$



Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

## Receiving Pattern ( $\phi$ ), $\vartheta = 90^{\circ}$



Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

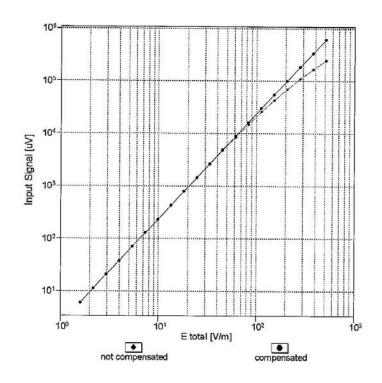
Certificate No: ER3-2272\_Jan16 Page 7 of 10

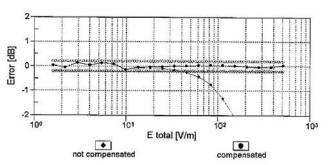


ER3DV6 - SN:2272

January 19, 2016

## Dynamic Range f(E-field) (TEM cell, f = 900 MHz)





Uncertainty of Linearity Assessment: ± 0.6% (k=2)

Certificate No: ER3-2272\_Jan16

Page 8 of 10



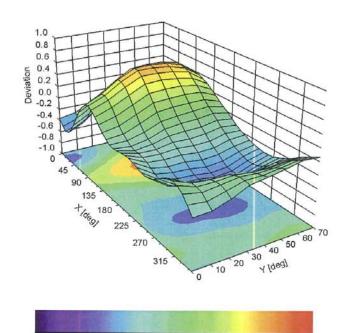
ER3DV6 - SN:2272

-0.8

-1.0

January 19, 2016

# Deviation from Isotropy in Air Error ( $\phi$ , $\vartheta$ ), f = 900 MHz



Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)

0.4

0.6

0.8

-0.6 -0.4 -0.2 0.0 0.2

Certificate No: ER3-2272\_Jan16

Page 9 of 10



ER3DV6 - SN:2272

January 19, 2016

## DASY/EASY - Parameters of Probe: ER3DV6 - SN:2272

#### **Other Probe Parameters**

Sensor Arrangement	Rectangular
Connector Angle (°)	113.1
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	10 mm
Tip Diameter	8 mm
Probe Tip to Sensor X Calibration Point	2.5 mm
Probe Tip to Sensor Y Calibration Point	2.5 mm
Probe Tip to Sensor Z Calibration Point	2.5 mm

Certificate No: ER3-2272\_Jan16



### ANNEX E DIPOLE CALIBRATION CERTIFICATE

#### Dipole 835 MHz

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA

Multilateral Agreement for the recognition of calibration certificates

Client

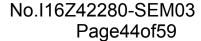
CTTL-BJ (Auden)

Certificate No: CD835V3-1023 Aug16

Object	CD835V3 - SN:	1023	
Calibration procedure(s)	QA CAL-20.v6		
ATATA	Calibration procedure for dipoles in air		
Calibration date:	August 31, 2016		
This calibration certificate docum	ents the traceability to pat	ional standards, which realize the physical ur	11-1
The measurements and the unce	ertainties with confidence of	orobability are given on the following pages a	nits of measurements (SI).
	Maritico With confidence p	and ability are given on the following pages a	nd are part of the certificate.
All calibrations have been condu	cted in the closed laborate	ry facility: environment temperature (22 ± 3)°	
	oted in the closed laborato	ry racinty, environment temperature (22 ± 3)	C and humidity < 70%.
Calibration Equipment used (M&	TE critical for calibration)		
Primary Standards	ID#	Cal Date (Certificate No.)	Cabadda d Oall
	100 11		Scheduled Calibration
Power meter NRP	SN: 104778		
	SN: 104778 SN: 103244	06-Apr-16 (No. 217-02288/02289)	Apr-17
Power sensor NRP-Z91	SN: 103244	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288)	Apr-17 Apr-17
Power sensor NRP-Z91 Power sensor NRP-Z91	SN: 103244 SN: 103245	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289)	Apr-17 Apr-17 Apr-17
Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator	SN: 103244 SN: 103245 SN: 5058 (20k)	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02292)	Apr-17 Apr-17 Apr-17 Apr-17
Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination	SN: 103244 SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02292) 05-Apr-16 (No. 217-02295)	Apr-17 Apr-17 Apr-17 Apr-17 Apr-17
Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination Probe ER3DV6	SN: 103244 SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 2336	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02292) 05-Apr-16 (No. 217-02295) 31-Dec-15 (No. ER3-2336_Dec15)	Apr-17 Apr-17 Apr-17 Apr-17 Apr-17 Dec-16
Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination Probe ER3DV6 Probe H3DV6	SN: 103244 SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 2336 SN: 6065	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02292) 05-Apr-16 (No. 217-02295) 31-Dec-15 (No. ER3-2336_Dec15) 31-Dec-15 (No. H3-6065_Dec15)	Apr-17 Apr-17 Apr-17 Apr-17 Apr-17 Dec-16 Dec-16
Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination Probe ER3DV6 Probe H3DV6	SN: 103244 SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 2336	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02292) 05-Apr-16 (No. 217-02295) 31-Dec-15 (No. ER3-2336_Dec15)	Apr-17 Apr-17 Apr-17 Apr-17 Apr-17 Dec-16
Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards	SN: 103244 SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02292) 05-Apr-16 (No. 217-02295) 31-Dec-15 (No. ER3-2336_Dec15) 31-Dec-15 (No. H3-6065_Dec15)	Apr-17 Apr-17 Apr-17 Apr-17 Apr-17 Dec-16 Dec-16
Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 4419B	SN: 103244 SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02292) 05-Apr-16 (No. 217-02295) 31-Dec-15 (No. ER3-2336_Dec15) 31-Dec-15 (No. H3-6065_Dec15) 04-Sep-15 (No. DAE4-781_Sep15)	Apr-17 Apr-17 Apr-17 Apr-17 Apr-17 Dec-16 Dec-16 Sep-16
Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 4419B	SN: 103244 SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02292) 05-Apr-16 (No. 217-02292) 05-Apr-16 (No. 217-02295) 31-Dec-15 (No. ER3-2336_Dec15) 31-Dec-15 (No. H3-6065_Dec15) 04-Sep-15 (No. DAE4-781_Sep15) Check Date (in house)	Apr-17 Apr-17 Apr-17 Apr-17 Apr-17 Dec-16 Dec-16 Sep-16 Scheduled Check
Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A	SN: 103244 SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781 ID # SN: GB42420191	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02292) 05-Apr-16 (No. 217-02295) 31-Dec-15 (No. ER3-2336_Dec15) 31-Dec-15 (No. H3-6065_Dec15) 04-Sep-15 (No. DAE4-781_Sep15) Check Date (in house)	Apr-17 Apr-17 Apr-17 Apr-17 Apr-17 Dec-16 Dec-16 Sep-16 Scheduled Check In house check: Oct-17
Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4  Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A Power sensor HP 8482A	SN: 103244 SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781 ID # SN: GB42420191 SN: US38485102	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02292) 05-Apr-16 (No. 217-02295) 31-Dec-15 (No. ER3-2336_Dec15) 31-Dec-15 (No. H3-6065_Dec15) 04-Sep-15 (No. DAE4-781_Sep15)  Check Date (in house) 09-Oct-09 (in house check Sep-14)	Apr-17 Apr-17 Apr-17 Apr-17 Apr-17 Dec-16 Dec-16 Sep-16 Scheduled Check In house check: Oct-17 In house check: Oct-17 In house check: Oct-17
Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4  Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A Power sensor HP 8482A RF generator R&S SMT-06	SN: 103244 SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781  ID # SN: GB42420191 SN: US38485102 SN: US37295597	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02292) 05-Apr-16 (No. 217-02292) 05-Apr-16 (No. 217-02295) 31-Dec-15 (No. ER3-2336_Dec15) 31-Dec-15 (No. H3-6065_Dec15) 04-Sep-15 (No. DAE4-781_Sep15)  Check Date (in house) 09-Oct-09 (in house check Sep-14) 09-Oct-09 (in house check Sep-14)	Apr-17 Apr-17 Apr-17 Apr-17 Apr-17 Dec-16 Dec-16 Sep-16 Scheduled Check In house check: Oct-17 In house check: Oct-17
Power meter NRP Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A Power sensor HP B482A RF generator R&S SMT-06 Network Analyzer HP 8753E	SN: 103244 SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781  ID # SN: GB42420191 SN: US38485102 SN: US37295597 SN: 832283/011 SN: US37390585  Name	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02292) 05-Apr-16 (No. 217-02292) 05-Apr-16 (No. 217-02295) 31-Dec-15 (No. ER3-2336_Dec15) 31-Dec-15 (No. H3-6065_Dec15) 04-Sep-15 (No. DAE4-781_Sep15)  Check Date (in house) 09-Oct-09 (in house check Sep-14) 09-Oct-09 (in house check Sep-14) 27-Aug-12 (in house check Oct-15)	Apr-17 Apr-17 Apr-17 Apr-17 Apr-17 Dec-16 Dec-16 Sep-16 Scheduled Check In house check: Oct-17 In house check: Oct-17 In house check: Oct-17 In house check: Oct-17
Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4  Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A Power sensor HP 8482A RF generator R&S SMT-06	SN: 103244 SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781  ID # SN: GB42420191 SN: US38485102 SN: US37295597 SN: 832283/011 SN: US37390585	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02292) 05-Apr-16 (No. 217-02292) 05-Apr-16 (No. ER3-2336_Dec15) 31-Dec-15 (No. ER3-2336_Dec15) 04-Sep-15 (No. DAE4-781_Sep15)  Check Date (in house) 09-Oct-09 (in house check Sep-14) 09-Oct-09 (in house check Sep-14) 27-Aug-12 (in house check Oct-15) 18-Oct-01 (in house check Oct-15)	Apr-17 Apr-17 Apr-17 Apr-17 Apr-17 Dec-16 Dec-16 Dec-16 Sep-16  Scheduled Check In house check: Oct-17 In house check: Oct-16 Signature
Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4  Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A Power sensor HP 8482A RF generator R&S SMT-06 Network Analyzer HP 8753E	SN: 103244 SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781  ID # SN: GB42420191 SN: US38485102 SN: US37295597 SN: 832283/011 SN: US37390585  Name	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02292) 05-Apr-16 (No. 217-02292) 05-Apr-16 (No. ER3-2336_Dec15) 31-Dec-15 (No. ER3-2336_Dec15) 04-Sep-15 (No. DAE4-781_Sep15)  Check Date (in house) 09-Oct-09 (in house check Sep-14) 09-Oct-09 (in house check Sep-14) 27-Aug-12 (in house check Oct-15) 18-Oct-01 (in house check Oct-15) Function	Apr-17 Apr-17 Apr-17 Apr-17 Apr-17 Apr-17 Dec-16 Dec-16 Sep-16  Scheduled Check In house check: Oct-17

Certificate No: CD835V3-1023\_Aug16

Page 1 of 8





Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
Servizio svizzero di taratura
Swiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA

Multilateral Agreement for the recognition of calibration certificates

#### References

- ANSI-C63.19-2007
   American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.
- [2] ANSI-C63.19-2011 American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

#### Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna
  (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes.
  In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a
  distance of 10 mm (15 mm for [2]) above the top metal edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All
  figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector
  is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a
  directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E-field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1] and [2], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 10 mm (15 mm for [2]) (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.
- H-field distribution: H-field is measured with an isotropic H-field probe with 100mW forward power to the
  antenna feed point, in the x-y-plane. The scan area and sensor distance is equivalent to the E-field scan. The
  maximum of the field is available at the center (subgrid 5) above the feed point. The H-field value stated as
  calibration value represents the maximum of the interpolated H-field, 10mm above the dipole surface at the
  feed point.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Certificate No: CD835V3-1023\_Aug16 Page 2 of 8



### **Measurement Conditions**

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.8.8
Phantom	HAC Test Arch	
Distance Dipole Top - Probe Center	10, 15 mm	
Scan resolution	dx, dy = 5 mm	
Frequency	835 MHz ± 1 MHz	
Input power drift	< 0.05 dB	

### Maximum Field values at 835 MHz

condition	interpolated maximum
100 mW input power	0.450 A/m ± 8.2 % (k=2)

E-field 10 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	166.0 V/m = 44.40 dBV/m
Maximum measured above low end	100 mW input power	159.9 V/m = 44.08 dBV/m
Averaged maximum above arm	100 mW input power	162.9 V/m ± 12.8 % (k=2)

E-field 15 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	106.4 V/m = 40.54 dBV/m
Maximum measured above low end	100 mW input power	104.5 V/m = 40.38 dBV/m
Averaged maximum above arm	100 mW input power	105.5 V/m ± 12.8 % (k=2)



## Appendix (Additional assessments outside the scope of SCS 0108)

#### **Antenna Parameters**

Frequency	Return Loss	Impedance
800 MHz	17.6 dB	40.9 Ω - 7.8 jΩ
835 MHz	24.6 dB	53.4 Ω + 5.0 jΩ
900 MHz	16.0 dB	52.5 Ω - 16.3 jΩ
950 MHz	21.8 dB	49.2 Ω + 8.0 jΩ
960 MHz	16.4 dB	60.1 Ω + 13.4 jΩ

#### 3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

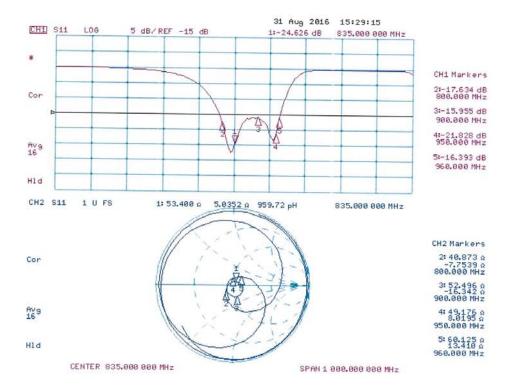
The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.



### Impedance Measurement Plot





#### **DASY5 H-field Result**

Date: 31.08.2016

Test Laboratory: SPEAG Lab2

## DUT: HAC-Dipole 835 MHz; Type: CD835V3; Serial: CD835V3 - SN: 1023

Communication System: UID 0 - CW ; Frequency: 835 MHz Medium parameters used:  $\sigma$  = 0 S/m,  $\epsilon_r$  = 1;  $\rho$  = 1 kg/m<sup>3</sup>

Phantom section: RF Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

#### DASY52 Configuration:

Probe: H3DV6 - SN6065; ; Calibrated: 31.12.2015

Sensor-Surface: (Fix Surface)

Electronics: DAE4 Sn781; Calibrated: 04.09.2015

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070

DASY52 52.8.8(1258); SEMCAD X 14.6.10(7372)

## Dipole H-Field measurement @ 835MHz/H-Scan - 835MHz d=10mm/Hearing Aid Compatibility Test (41x361x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

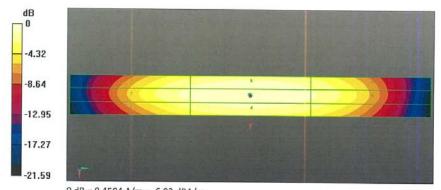
Reference Value = 0.4780 A/m; Power Drift = -0.01 dB

PMR not calibrated. PMF = 1.000 is applied.

H-field emissions = 0.4504 A/m Near-field category: M4 (AWF 0 dB)

PMF scaled H-field

The state of the s	Grid 2 M4	CONTRACTOR PROFITAGE
0.370 A/m	0.405 A/m	0.391 A/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
0.415 A/m	0.450 A/m	0.438 A/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
0.364 A/m	0.395 A/m	0.384 A/m



0 dB = 0.4504 A/m = -6.93 dBA/m

Certificate No: CD835V3-1023\_Aug16



#### **DASY5 E-field Result**

Date: 31.08.2016

Test Laboratory: SPEAG Lab2

DUT: HAC-Dipole 835 MHz; Type: CD835V3; Serial: CD835V3 - SN: 1023

Communication System: UID 0 - CW ; Frequency: 835 MHz Medium parameters used:  $\sigma = 0$  S/m,  $\epsilon_r = 1$ ;  $\rho = 1000$  kg/m<sup>3</sup>

Phantom section: RF Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

#### DASY52 Configuration:

Probe: ER3DV6 - SN2336; ConvF(1, 1, 1); Calibrated: 31.12.2015;

Sensor-Surface: (Fix Surface)

Electronics: DAE4 Sn781; Calibrated: 04.09.2015

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070

DASY52 52.8.8(1258); SEMCAD X 14.6.10(7372)

Dipole E-Field measurement @ 835MHz/E-Scan - 835MHz d=10mm/Hearing Aid Compatibility Test (41x361x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 108.1 V/m; Power Drift = -0.01 dB Applied MIF = 0.00 dB RF audio interference level = 44.40 dBV/m Emission category: M3

MIF scaled E-fi	eld	
	Grid 2 M3 44.08 dBV/m	Grid 3 M3 43.83 dBV/m
	Grid 5 M4 38.79 dBV/m	Grid 6 M4 38.51 dBV/m
Grid 7 M3 43.98 dBV/m	and the second second second	Grid 9 M3 44.21 dBV/m

Certificate No: CD835V3-1023\_Aug16



Dipole E-Field measurement @ 835MHz/E-Scan - 835MHz d=15mm/Hearing Aid Compatibility Test (41x361x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 108.0 V/m; Power Drift = -0.02 dB

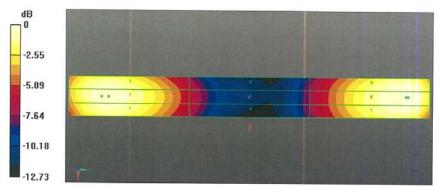
Applied MIF = 0.00 dB

RF audio interference level = 40.54 dBV/m

Emission category: M3

MIF scaled E-field

A STATE OF THE PARTY OF THE PAR	Grid 3 M3 40.23 dBV/m
	Grid 6 M4 35.73 dBV/m
Grid 8 M3 40.54 dBV/m	



0 dB = 166.0 V/m = 44.40 dBV/m



#### Dipole 1880 MHz

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Client CTTL-BJ (Auden)

Object	CD1880V3 - SN: 1018		
Calibration procedure(s)	QA CAL-20.v6		
	Calibration proce	edure for dipoles in air	
Calibration date:	August 31, 2016		
This calibration certificate docum	ents the traceability to not	anal standards, which realize the abovious	14-1
The measurements and the unce	ertainties with confidence o	onal standards, which realize the physical un robability are given on the following pages ar	its of measurements (SI).
		are given on the following pages ar	id are part of the certificate.
All calibrations have been conduc	cted in the closed laborato	ry facility: environment temperature (22 ± 3)°0	C and humidity < 70%.
Calibration Equipment used (M&			
	Thomas and the	Cal Date (Certificate No.)	Cahadulad Calibration
Primary Standards	ID#	Cal Date (Certificate No.)	Scheduled Calibration
Primary Standards Power meter NRP	ID # SN: 104778	06-Apr-16 (No. 217-02288/02289)	Apr-17
Primary Standards Power meter NRP Power sensor NRP-Z91	ID#	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288)	Apr-17 Apr-17
Primary Standards Power meter NRP Power sensor NRP-Z91 Power sensor NRP-Z91	ID # SN: 104778 SN: 103244 SN: 103245	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289)	Apr-17 Apr-17 Apr-17
Power meter NRP Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator	ID # SN: 104778 SN: 103244 SN: 103245 SN: 5058 (20k)	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02292)	Apr-17 Apr-17 Apr-17 Apr-17
Primary Standards Power meter NRP Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination	ID # SN: 104778 SN: 103244 SN: 103245	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02292) 05-Apr-16 (No. 217-02295)	Apr-17 Apr-17 Apr-17 Apr-17 Apr-17
Primary Standards Power meter NRP Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mlsmatch combination Probe ER3DV6	ID #  SN: 104778 SN: 103244 SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02292) 05-Apr-16 (No. 217-02295) 31-Dec-15 (No. ER3-2336_Dec15)	Apr-17 Apr-17 Apr-17 Apr-17 Apr-17 Dec-16
Primary Standards Power meter NRP Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination Probe ER3DV6 Probe H3DV6	ID #  SN: 104778 SN: 103244 SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 2336	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02292) 05-Apr-16 (No. 217-02295)	Apr-17 Apr-17 Apr-17 Apr-17 Apr-17
Primary Standards Power meter NRP Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4	ID #  SN: 104778 SN: 103244 SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 2336 SN: 6065	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02292) 05-Apr-16 (No. 217-02295) 31-Dec-15 (No. ER3-2336_Dec15) 31-Dec-15 (No. H3-6065_Dec15)	Apr-17 Apr-17 Apr-17 Apr-17 Apr-17 Dec-16 Dec-16
Primary Standards Power meter NRP Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards	ID #  SN: 104778 SN: 103244 SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02292) 05-Apr-16 (No. 217-02295) 31-Dec-15 (No. ER3-2336_Dec15) 31-Dec-15 (No. H3-6065_Dec15) 04-Sep-15 (No. DAE4-781_Sep15)	Apr-17 Apr-17 Apr-17 Apr-17 Apr-17 Dec-16 Dec-16 Sep-16
Primary Standards Power meter NRP Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4  Secondary Standards Power meter Agilent 4419B	ID #  SN: 104778 SN: 103244 SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02292) 05-Apr-16 (No. 217-02292) 31-Dec-15 (No. ER3-2336_Dec15) 31-Dec-15 (No. H3-6065_Dec15) 04-Sep-15 (No. DAE4-781_Sep15) Check Date (in house)	Apr-17 Apr-17 Apr-17 Apr-17 Apr-17 Apr-17 Dec-16 Dec-16 Sep-16 Scheduled Check
Primary Standards Power meter NRP Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4  Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A Power sensor HP 8482A	ID #  SN: 104778 SN: 103244 SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781  ID #  SN: GB42420191	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02292) 05-Apr-16 (No. 217-02292) 05-Apr-16 (No. 217-02295) 31-Dec-15 (No. ER3-2336_Dec15) 31-Dec-15 (No. H3-6065_Dec15) 04-Sep-15 (No. DAE4-781_Sep15) Check Date (in house) 09-Oct-09 (in house check Sep-14)	Apr-17 Apr-17 Apr-17 Apr-17 Apr-17 Apr-17 Dec-16 Dec-16 Sep-16 Scheduled Check In house check: Oct-17
Primary Standards Power meter NRP Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4  Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A Power sensor HP 8482A	ID #  SN: 104778 SN: 103244 SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781  ID #  SN: GB42420191 SN: US38485102	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02292) 05-Apr-16 (No. 217-02295) 31-Dec-15 (No. ER3-2336_Dec15) 31-Dec-15 (No. H3-6065_Dec15) 04-Sep-15 (No. DAE4-781_Sep15)  Check Date (in house) 09-Oct-09 (in house check Sep-14)	Apr-17 Apr-17 Apr-17 Apr-17 Apr-17 Apr-17 Dec-16 Dec-16 Sep-16 Scheduled Check In house check: Oct-17 In house check: Oct-17
Primary Standards Power meter NRP Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4  Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A Power sensor HP 8482A RF generator R&S SMT-06	ID #  SN: 104778 SN: 103244 SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781  ID #  SN: GB42420191 SN: US38485102 SN: US37295597	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02292) 05-Apr-16 (No. 217-02292) 31-Dec-15 (No. ER3-2336_Dec15) 31-Dec-15 (No. H3-6065_Dec15) 04-Sep-15 (No. DAE4-781_Sep15)  Check Date (in house) 09-Oct-09 (in house check Sep-14) 09-Oct-09 (in house check Sep-14)	Apr-17 Apr-17 Apr-17 Apr-17 Apr-17 Apr-17 Dec-16 Dec-16 Sep-16 Scheduled Check In house check: Oct-17 In house check: Oct-17
Primary Standards Power meter NRP Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4  Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A Power sensor HP B482A RF generator R&S SMT-06 Network Analyzer HP 8753E	ID #  SN: 104778 SN: 103244 SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781  ID #  SN: GB42420191 SN: US38485102 SN: US37295597 SN: 832283/011 SN: US37390585  Name	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02292) 05-Apr-16 (No. 217-02292) 05-Apr-16 (No. ER3-2336_Dec15) 31-Dec-15 (No. ER3-2336_Dec15) 04-Sep-15 (No. DAE4-781_Sep15)  Check Date (in house) 09-Oct-09 (in house check Sep-14) 09-Oct-09 (in house check Sep-14) 27-Aug-12 (in house check Oct-15)	Apr-17 Apr-17 Apr-17 Apr-17 Apr-17 Apr-17 Dec-16 Dec-16 Sep-16 Scheduled Check In house check: Oct-17 In house check: Oct-17 In house check: Oct-17 In house check: Oct-17
Primary Standards Power meter NRP Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4  Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A Power sensor HP B482A RF generator R&S SMT-06 Network Analyzer HP 8753E	ID #  SN: 104778 SN: 103244 SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781  ID #  SN: GB42420191 SN: US38485102 SN: US37295597 SN: 832283/011 SN: US37390585	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02292) 05-Apr-16 (No. 217-02292) 05-Apr-16 (No. 217-02295) 31-Dec-15 (No. ER3-2336_Dec15) 31-Dec-15 (No. H3-6065_Dec15) 04-Sep-15 (No. DAE4-781_Sep15)  Check Date (in house) 09-Oct-09 (in house check Sep-14) 09-Oct-09 (in house check Sep-14) 27-Aug-12 (in house check Oct-15) 18-Oct-01 (in house check Oct-15)	Apr-17 Apr-17 Apr-17 Apr-17 Apr-17 Apr-17 Dec-16 Dec-16 Dec-16 Sep-16  Scheduled Check In house check: Oct-17
Primary Standards Power meter NRP Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4  Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A Power sensor HP 8482A RF generator R&S SMT-06	ID #  SN: 104778 SN: 103244 SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781  ID #  SN: GB42420191 SN: US38485102 SN: US37295597 SN: 832283/011 SN: US37390585  Name	06-Apr-16 (No. 217-02288/02289) 06-Apr-16 (No. 217-02288) 06-Apr-16 (No. 217-02289) 05-Apr-16 (No. 217-02292) 05-Apr-16 (No. 217-02292) 05-Apr-16 (No. 217-02295) 31-Dec-15 (No. ER3-2336_Dec15) 31-Dec-15 (No. H3-6065_Dec15) 04-Sep-15 (No. DAE4-781_Sep15)  Check Date (in house) 09-Oct-09 (in house check Sep-14) 09-Oct-09 (in house check Sep-14) 27-Aug-12 (in house check Oct-15) 18-Oct-01 (in house check Oct-15) Function	Apr-17 Apr-17 Apr-17 Apr-17 Apr-17 Apr-17 Dec-16 Dec-16 Sep-16 Scheduled Check In house check: Oct-17

Certificate No: CD1880V3-1018\_Aug16

Page 1 of 8





Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





Schweizerischer Kalibrierdienst Service suisse d'étalonnage C Servizio svizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 0108

S

S

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

#### References

[1] ANSI-C63.19-2007 American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

[2] ANSI-C63.19-2011 American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

#### Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a distance of 10 mm (15 mm for [2]) above the top metal edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E-field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1] and [2], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 10 mm (15 mm for [2]) (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-Efield, in the plane above the dipole surface.
- H-field distribution: H-field is measured with an isotropic H-field probe with 100mW forward power to the antenna feed point, in the x-y-plane. The scan area and sensor distance is equivalent to the E-field scan. The maximum of the field is available at the center (subgrid 5) above the feed point. The H-field value stated as calibration value represents the maximum of the interpolated H-field, 10mm above the dipole surface at the

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Certificate No: CD1880V3-1018\_Aug16 Page 2 of 8



#### Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.8.8
Phantom	HAC Test Arch	
Distance Dipole Top - Probe Center	10, 15 mm	*
Scan resolution	dx, dy = 5 mm	
Frequency	1880 MHz ± 1 MHz	
Input power drift	< 0.05 dB	

### Maximum Field values at 1880 MHz

H-field 10 mm above dipole surface	condition	interpolated maximum
Maximum measured	100 mW input power	0.457 A/m ± 8.2 % (k=2)

E-field 10 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	142.3 V/m = 43.06 dBV/m
Maximum measured above low end	100 mW input power	137.7 V/m = 42.78 dBV/m
Averaged maximum above arm	100 mW input power	140.0 V/m ± 12.8 % (k=2)

E-field 15 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	92.8 V/m = 39.35 dBV/m
Maximum measured above low end	100 mW input power	87.5 V/m = 38.84 dBV/m
Averaged maximum above arm	100 mW input power	90.2 V/m ± 12.8 % (k=2)



## Appendix (Additional assessments outside the scope of SCS 0108)

#### **Antenna Parameters**

Frequency	Return Loss	Impedance
1730 MHz	28.6 dB	53.8 Ω + 0.5 jΩ
1880 MHz	21.9 dB	55.2 Ω + 6.6 jΩ
1900 MHz	22.5 dB	56.5 Ω + 4.6 jΩ
1950 MHz	34.6 dB	51.9 Ω + 0.0 jΩ
2000 MHz	18.9 dB	47.2 Ω + 10.7 jΩ

#### 3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

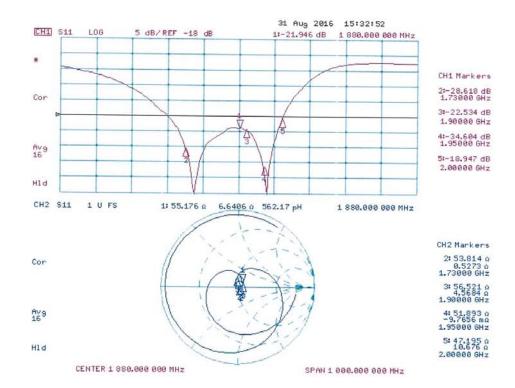
The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.



#### Impedance Measurement Plot





#### **DASY5 H-field Result**

Date: 31.08.2016

Test Laboratory: SPEAG Lab2

#### DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: CD1880V3 - SN: 1018

Communication System: UID 0 - CW ; Frequency: 1880 MHz Medium parameters used:  $\sigma$  = 0 S/m,  $\epsilon_r$  = 1;  $\rho$  = 1 kg/m<sup>3</sup>

Phantom section: RF Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

#### DASY52 Configuration:

- Probe: H3DV6 SN6065; ; Calibrated: 31.12.2015
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 04.09.2015
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.8.8(1258); SEMCAD X 14.6.10(7372)

## $Dipole\ H-Field\ measurement\ @\ 1880MHz/H-Scan\ -\ 1880MHz\ d=10mm/Hearing\ Aid\ Compatibility\ Test\ (41x181x1):$

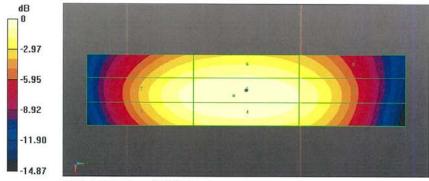
Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 0.4760 A/m; Power Drift = 0.01 dB PMR not calibrated. PMF = 1.000 is applied.

H-field emissions = 0.4569 A/m

Near-field category: M2 (AWF 0 dB)

PMF scaled H-field

Grid 1 M2	Grid 2 M2	Grid 3 M2
0.428 A/m	0.433 A/m	0.394 A/m
Grid 4 M2	Grid 5 M2	Grid 6 M2
0.451 A/m	0.457 A/m	0.419 A/m
Grid 7 M2	Grid 8 M2	Grid 9 M2
0.406 A/m	0.410 A/m	0.371 A/m



0 dB = 0.4569 A/m = -6.80 dBA/m

Certificate No: CD1880V3-1018\_Aug16





#### **DASY5 E-field Result**

Date: 31.08.2016

Test Laboratory: SPEAG Lab2

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: CD1880V3 - SN: 1018

Communication System: UID 0 - CW ; Frequency: 1880 MHz Medium parameters used:  $\sigma$  = 0 S/m,  $\epsilon_r$  = 1;  $\rho$  = 1000 kg/m<sup>3</sup> Phantom section: RF Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

#### DASY52 Configuration:

Probe: ER3DV6 - SN2336; ConvF(1, 1, 1); Calibrated: 31.12.2015;

Sensor-Surface: (Fix Surface)

Electronics: DAE4 Sn781; Calibrated: 04.09.2015

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070

DASY52 52.8.8(1258); SEMCAD X 14.6.10(7372)

Dipole E-Field measurement @ 1880MHz/E-Scan - 1880MHz d=10mm/Hearing Aid Compatibility Test (41x181x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 154.2 V/m; Power Drift = -0.03 dB Applied MIF = 0.00 dB RF audio interference level = 43.06 dBV/m

Emission category: M1

Certificate No: CD1880V3-1018\_Aug16

#### MIF scaled E-field

0000000 H 000000000	Grid 2 M1 43.06 dBV/m	Grid 3 M1 42.75 dBV/m
Design County	Grid 5 M2 39.06 dBV/m	Grid 6 M2 38.62 dBV/m
Account Learning	Grid 8 M1 42.78 dBV/m	Grid 9 M1 42.25 dBV/m

Page 7 of 8



 $Dipole\ E-Field\ measurement\ @\ 1880MHz/E-Scan\ -\ 1880MHz\ d=15mm/Hearing\ Aid\ Compatibility\ Test\ (41x181x1):$ 

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 153.7 V/m; Power Drift = 0.01 dB

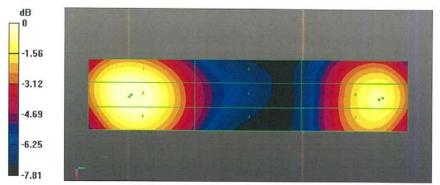
Applied MIF = 0.00 dB

RF audio interference level = 39.35 dBV/m

Emission category: M2

MIF scaled E-field

	Grid 2 M2 39.35 dBV/m	Grid 3 M2 39.19 dBV/m
		Grid 6 M2 36.81 dBV/m
Bearing Colors of the Colors o		Grid 9 M2 38.62 dBV/m



0 dB = 142.3 V/m = 43.06 dBV/m

Page 8 of 8



## The photos of HAC test are presented in the additional document:

Appendix to test report No.I16Z42280-SEM03

The photos of HAC test